# **MOSFET** - Power, Single, **N-Channel, DPAK** 40 V, 38 A

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- Low Gate Charge
- STD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable\*
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltag	$V_{DSS}$	40	V		
Gate-to-Source Voltag	е		V <sub>GS</sub>	±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	38	Α
Current – R <sub>θJC</sub>	State	T <sub>C</sub> = 100°C		27	
Power Dissipation – $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	75	W
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	7.6	Α
Current R <sub>θJA</sub> (Note 1)	State	T <sub>A</sub> = 100°C		5.3	
Power Dissipation – R <sub>θJA</sub> (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	2.9	W
Pulsed Drain Current	t <sub>p</sub> :	= 10 μs	I <sub>DM</sub>	75	Α
Operating Junction and	T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C		
Source Current (Body Diode)			Is	36	Α
Single Pulse Drain-to S Energy – ( $V_{DD}$ = 50 V, $V_{DD}$ = 1 mH, $V_{CM}$ = 25 $V_{CM}$ )	EAS	150	mJ		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

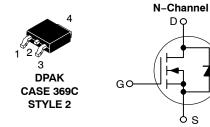
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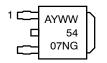
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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX (Note 1)
40 V	21 mΩ @ 10 V	38 A



#### **MARKING DIAGRAM**



= Assembly Location\*

= Year WW

= Work Week

= Specific Device Code 5407N = Pb-Free Device

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### ORDERING INFORMATION

Device	Package	Shipping†
NTD5407NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
STD5407NT4G*	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5407NT4G*	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	2.0	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	52	°C/W

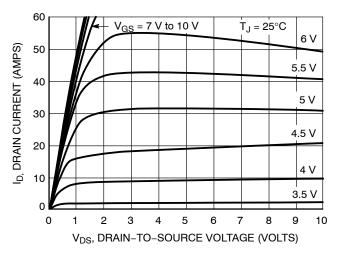
Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				39		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 40 \text{ V}$	T <sub>J</sub> = 100°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_0$	<sub>SS</sub> = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{E}$	) = 250 μΑ	1.5		3.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 20 A		21	26	mΩ
		V <sub>GS</sub> = 5.0 V,	I <sub>D</sub> = 10 A		32	40	
Forward Transconductance	g <sub>FS</sub>	V <sub>GS</sub> = 10 V,	I <sub>D</sub> = 18 A		15		S
CHARGES AND CAPACITANCES			•				
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,} $ $V_{DS} = 32 \text{ V}$			615	1000	pF
Output Capacitance	C <sub>OSS</sub>				173		
Reverse Transfer Capacitance	C <sub>RSS</sub>	<b>V</b> DS - <b>V</b>	,		80		
Total Gate Charge	Q <sub>G(TOT)</sub>				20		nC
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 10 \text{ V, V}$ $I_{D} = 3$	<sub>DS</sub> = 32 V,		2.25		
Gate-to-Drain Charge	$Q_{GD}$	10 - 3	371		10.5		
SWITCHING CHARACTERISTICS, Vo	GS = 10 V (Note	3)					
Turn-On Delay Time	t <sub>d(ON)</sub>				6.8		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V	nn = 32 V,		17		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 32 \text{ V},$ $I_D = 38 \text{ A}, R_G = 2.5 \Omega$			66		
Fall Time	t <sub>f</sub>		Ī		51		
SWITCHING CHARACTERISTICS, Vo	GS = <b>5 V</b> (Note 3	)	•			•	
Turn-On Delay Time	t <sub>d(ON)</sub>				10		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 5 V, V <sub>I</sub>	nn = 20 V.		175		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	I <sub>D</sub> = 20 A, R	$G = 2.5 \Omega$		13		
Fall Time	t <sub>f</sub>				23		
DRAIN-SOURCE DIODE CHARACTE	RISTICS (Note	2)	•		-	-	•
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 5.0 A	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$		0.9 0.75	1.1	V
Reverse Recovery Time	too		13 - 123 0		38		ns
Charge Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, \text{ dI}_S/\text{dt} = 100 \text{ A}/\mu\text{s},$ $I_S = 15 \text{ A}$			20.5		- 113
Discharge Time	t <sub>a</sub>				17		-
	t <sub>b</sub>						
Reverse Recovery Charge	Q <sub>RR</sub>				40		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 
2. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 
3. Switching characteristics are independent of operating junction temperatures.

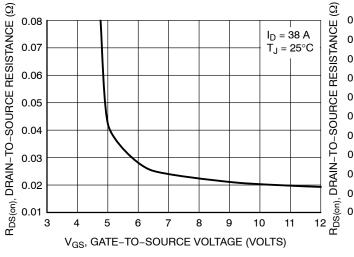
#### **TYPICAL PERFORMANCE CURVES**



60  $V_{DS} \ge 10 \text{ V}$ ID, DRAIN CURRENT (AMPS) 50 40 30 20  $T_J = 100^{\circ}C$ 10 T<sub>J</sub> = 25°C  $T_J = -55^{\circ}C$ 0 0 3 6 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



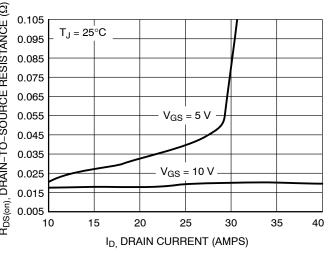
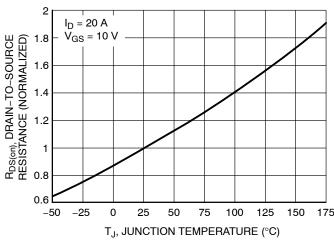


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



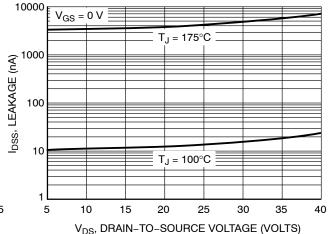
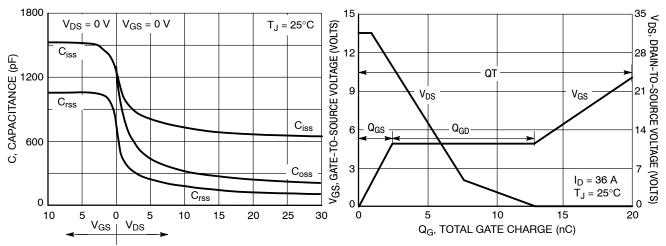


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

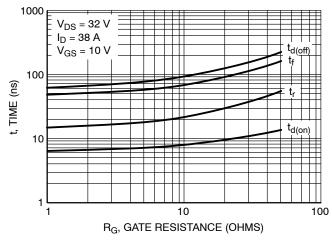


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

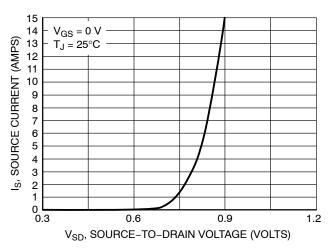


Figure 10. Diode Forward Voltage vs. Current

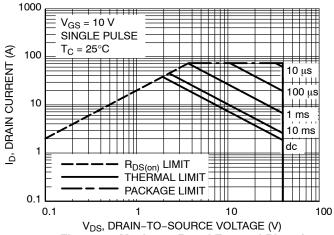
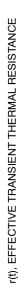


Figure 11. Maximum Rated Forward Biased Safe Operating Area

### **TYPICAL PERFORMANCE CURVES**



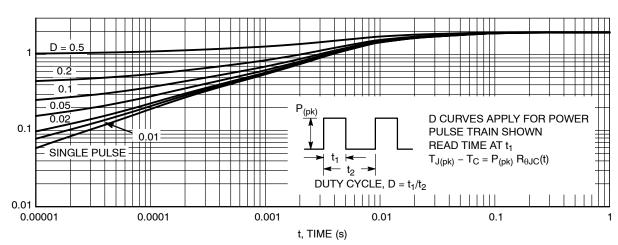


Figure 12. Thermal Response

В

NOTE 7

- h3

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**TOP VIEW** 

L3

b2 e

## **DPAK (SINGLE GAUGE)** CASE 369C **ISSUE F** SCALE 1:1 Α

DETAIL A

C-

SIDE VIEW

**DATE 21 JUL 2015** 

#### NOTES:

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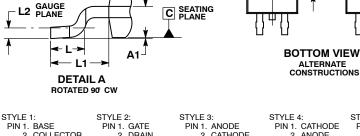
**BOTTOM VIEW** 

Z

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-
- MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

  6. DATUMS A AND B ARE DETERMINED AT DATUM
- 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



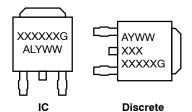
|  $\oplus$  | 0.005 (0.13) lacktriangledown C

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#### STYLE 5: PIN 1. BASE 2. COLLECTOR 3. EMITTER PIN 1. GATE 2. DRAIN PIN 1. ANODE 2. CATHODE 3. ANODE PIN 1. CATHODE PIN 1. GATE 2. ANODE 3. CATHODE 2. ANODE 3. GATE SOURCE 4. CATHODE ANODE 4. COLLECTOR 4. ANODE 4. DRAIN

STYLE 6:	STYLE 7:	STYLE 8:	STYLE 9:	STYLE 10:
PIN 1. MT1	PIN 1. GATE	PIN 1. N/C	PIN 1. ANODE	PIN 1. CATHODE
2. MT2	2. COLLECTOR	<ol><li>CATHODE</li></ol>	2. CATHODE	<ol><li>ANODE</li></ol>
3. GATE	<ol><li>EMITTER</li></ol>	<ol><li>ANODE</li></ol>	<ol><li>RESISTOR ADJUST</li></ol>	<ol><li>CATHODE</li></ol>
4. MT2	<ol><li>COLLECTOR</li></ol>	4. CATHODE	4. CATHODE	4. ANODE

#### **GENERIC MARKING DIAGRAM\***

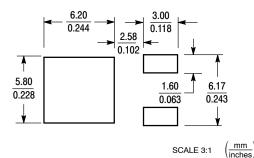


XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year

WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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